## Search Notes



Application/Control No.		Applicant(s)/Patent Under Reexamination	
10564918		LEECH, LINDA	
Examiner		Art Unit	
Chen, Junpeng		2618	

SEARCHED					
Class	Subclass	Date	Examiner		
455	574; 343.1; 343.2; 343.5; 127.5	11/17/2006	J.C.		
455	572,573,574,127.1,127.2,127.5,343.1-343.6	05/05/2007	J.C.		
700	65	05/05/2007	J.C.		

SEARCH NOTES				
Search Notes	Date	Examiner		
EAST Image and keyword search in USPAT, US-PGPub, DERWENT, EPO, JPO and IBM_TDB	11/17/2006	J.C.		
Consulted with Richard Chan and Rafael Perez-Gutierrez on claims 12-13 with 101 rejection	11/17/2006	J.C.		
Consulted with John Peng on claims 11-13 with 101 and 112 rejections	11/17/2006	J.C.		

INTERFERENCE SEARCH				
Subclass	Date	Examine		

Part of Paper No.: 20070504